

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re U.S. Patent Application of:

Applicant(s): Bradbury et al.

Serial No.: 10/002,680

Conf No.: 4637

Filed: October 23, 2001

For: IDENTIFICATION OF MATERIAL
INCLUSIONS IN PULP AND PAPER
USING RAMAN SPECTROSCOPY

Art Unit: 2877

Examiner: Lauchman, Layla



I hereby certify that this paper is being deposited with the United States Postal Service as FIRST-CLASS mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on this date

12/3/03

Date

Attorney for Applicant(s)

Registration No. 30,270

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

This IDS is submitted under 37 C.F.R. §1.97(c), after the C.F.R. §1.97(b) time period, but before the mail date of a Final Office Action or a Notice of Allowance (whichever occurs first), with either:

- (a) a statement under 37 C.F.R. §1.97(e); or
- (b) the \$180.00 fee under 37 C.F.R. §1.17(p).

Applicant(s) submit herewith Form PTO-1449 (Information Disclosure Citation) together with copies of patents, publications or other information of which applicant(s) are aware, which applicant(s) believe may be material to the examination of this application and for which there may be a duty to disclose in accordance with 37 C.F.R. §1.56. Applicant(s) respectfully submit that the citation of any reference on Form PTO-1449 does not constitute an admission that the reference qualifies as prior art.

It is requested that the information disclosed on the enclosed Form PTO-1449 be made of record in this application.

() Statement Under 37 C.F.R. §1.97(e):

() The enclosed references were cited in a Communication issued by the Patent Office (copy enclosed). Applicant(s) hereby certify that each item of information cited on the enclosed Form PTO-1449 was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three (3) months prior to the filing of this Information Disclosure Statement.

() Applicant(s) hereby certify that no item of information cited on the enclosed Form PTO-1449 was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing below after making reasonable inquiry, no item of information cited on the enclosed Form PTO-1449 was known to any individual designated in §1.56(c) more than three months prior to the filing of this Information Disclosure Statement.

(X) Enclosed is a check for \$180.00 to cover the fee as set forth in 37 C.F.R. §1.17(p).

The Commissioner is hereby authorized to charge any additional fees which may be required to this application under 37 C.F.R. §§1.16-1.17, or to credit any overpayment, to Deposit Account No. 07-2069. A duplicate copy of this sheet is enclosed.

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Respectfully submitted,
GREER, BURNS & CRAIN, LTD.

By:

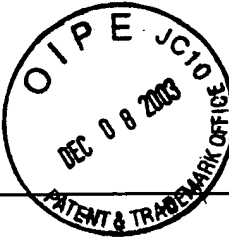
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Form PTO-1449 (Rev. 8-88)		U.S. Department of Commerce Patent and Trademark Office				Attorney Docket No. 0329.63829		Serial No. 10/002,680						
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)						Applicant: Bradbury et al.								
						Filing Date: October 23, 2001		Group No. 2877						
U.S. PATENT DOCUMENTS														
Examiner initial*		Document No.						Date	Name	Class	Subclass	Filing Date		
		4	6	2	0	1	8	4	October 28, 1986	Nedstedt			February 19, 1985	
		4	0	6	6	4	9	2	January 3, 1978	Hill			May 12, 1976	
FOREIGN PATENT DOCUMENTS														
		Document No.						Date	Country	Class	Subclass	Translation		
												Yes	No	
WO	0	1	4	8	4	7	2	1	December 20, 2000	PCT			Yes	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)														
	Measurements of Paper Coating Properties by NIR and Raman Spectroscopy Methods Jouni Tornberg, Juha Sumen, Janne Suhonen and Pentti Niemela; VTT Electronics; Trondheim, June 7, 2000. /													
Examiner _____ Date Considered _____														
*Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														